

<b>Notice of References Cited</b>	Application/Control No. 10/664,500		Applicant(s)/Patent Under Reexamination YALOVSKY, MARK	
	Examiner Maikhanh Nguyen		Art Unit 2176	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,613,019	03-1997	Altman et al.	382/189
*	B	US-6,088,481 A	07-2000	Okamoto et al.	382/189
*	C	US-7,043,689 B2	05-2006	Linker et al.	715/526
*	D	US-7,167,165 B2	01-2007	Keely et al.	345/179
*	E	US-2002/0064308	05-2002	ALTMAN et al.	382/187
*	F	US-2002/0178008 A1	11-2002	Reynar, Jeff	704/272
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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